

<b>Notice of References Cited</b>	Application/Control No. 10/813,952	Applicant(s)/Patent Under Reexamination BAEK, JAE-MYUNG	
	Examiner Stephen E. Jones	Art Unit 2817	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,366,466	04-2002	Leddige et al.	361/760
	C	US-6,392,164	05-2002	Iwaki et al.	174/262
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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